

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION

ATTY. DOCKET NO.
62807-037

SERIAL NO.

(PTO-1449)

FILING DATE

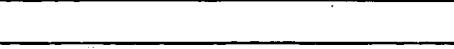
FILING DATE	GROUP
February 14, 2002	

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER	DATE CONSIDERED
	22 JUL 05

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INFORMATION DISCLOSURE CITATION IN AN APPLICATION  (PTO-1449)			ATTY. DOCKET NO. 62807-037	SERIAL NO. 10/074,239			
			APPLICANT Shinji ITOH, et al.				
			FILING DATE February 14, 2002	GROUP 2131			
U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS			
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
<i>TS</i>	8-204701	8/9/1996	Japan (w/ English Abstract)				
<i>TS</i>	11-149385	6/2/1999	Japan (w/ English Abstract)				
<i>TS</i>	11-85546	3/30/1999	Japan (w/ English Abstract)				
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
<i>TS</i>	"Department of Defense Trusted Computer System Evaluation Criteria", DOD, 5200.28-STD, December 26, 1985, pp. 1-116.						
EXAMINER	DATE CONSIDERED <i>22-JUL-05</i>						

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SHEET 1 OF 1

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U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
	US	5,577,209	11/19/1995	Boyle et al.		
	US	5,680,452	10/21/1997	Shanton		
	US	6,772,419 B1	08/03/2004	Sekiguchi et al.		
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FOREIGN PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number & Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation
		WO 00/10278	02/24/2000	CRYPTEK SECURE COMMUNICATIONS, LLC.		X
		EP 0 743 777 A2	11/20/1996	SUN MICROSYSTEMS, INC.		X
		JP 11-149385	06/02/1999	HITACHI LTD.		JAPAN (w/ENGLISH ABSTRACT)
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				
EXAMINER			DATE CONSIDERED			

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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.